

Search Notes

Application/Control No.

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Examiner

Erin D. Chiem

Applicant(s)/Patent under
Reexamination

SHIMIZU ET AL.

Art Unit

2883

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
385/14,18,24,50 and text search; see search notes	8/21/2005	EDC
257/21,53-56,72,113-118,184-189,225-234,257-258,290-294,414,431-466,446,499-564 and text search; see search notes	6/21/2005	EDC
PLUS search	6/21/2005	EDC